Notice of References Cited Application/Control No. 10/784,470 Examiner Suman Debnath Applicant(s)/Patent Under Reexamination TAJIMA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0138754 A1	09-2002	Himeno, Toshihiko	713/200
*	В	US-5,379,343	01-1995	Grube et al.	455/410
*	O	US-2001/0014884 A1	08-2001	DILLARD et al.	705/57
	۵	US-			
	ш	US-		•	
	F	US-			
	G	US-			
	H	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	α					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

	NON-FATERI DOCUMENTS						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	٧						
	w						
	x						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYYY format are publication dates. Classifications may be US or foreign.